## Notice of References Cited Application/Control No. 10/801,040 Examiner Richard Chang Applicant(s)/Patent Under Reexamination HETHUIN ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,366,569	04-2002	Ritter, Gerhard	370/337
	В	US-2003/0063597	04-2003	Suzuki, Mitsuhiro	370/347
	С	US-2004/0008617	01-2004	Dabak et al.	370/208
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N							
	0							
	Р							
	Ö			-				
	R			-				
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.